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	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/750,567	MCALPINE ET AL.
	Examiner	Art Unit
_	Yaima Campos	2185

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Class	Subclass	Date	Examiner	
711	203			
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Consulted Primary Examiner Nasser G. Moazzami	10/27/2006	YC
Updated EAST text search	10/27/2006	YC
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